


<b>Search Notes</b>  	<b>Application/Control No.</b>  10581076	<b>Applicant(s)/Patent Under Reexamination</b>  YAMASHITA ET AL.
	<b>Examiner</b>  DAVID L LEWIS	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	55-100, 204-214	3/2/09	DL
326	62-98	3/2/09	DL
327	333	3/2/09	DL

SEARCH NOTES			
Search Notes		Date	Examiner
EAST SEARCH, keywords and subclass, uspat, uspgpubs, epo, jpo, derwent, ibm_db; inventor name search;		3/2/09	DL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
see the above search;		3/2/09	DL

/DAVID L LEWIS/  
Examiner,Art Unit 2629